

### Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Input Control Current, Relay	50	mA
Input Control Current, Detector	100	mA
Total Package Dissipation <sup>1</sup>	1	W
Isolation Voltage, Input to Output	3750	V <sub>rms</sub>
Operational Temperature	-40 to +85	°C
Storage Temperature	-40 to +125	°C

<sup>1</sup> Derate linearly 8.33 mW / °C

Total Power Dissipation (PD):

$$P_D = P_{\text{HOOKSWITCH}} + P_{\text{BRIDGE}} + P_{\text{DARLINGTON}} + P_{\text{LED}}$$

$$P_D = (R_{DS(on)})(I_F^2) + 2(V_F)(I_L) + (V_{CE})(I_L) + (V_{LED})(I_F)$$

WHERE:

$R_{DS(on)}$  = Maximum relay on resistance

$I_L$  = Maximum loop current

$V_F$  = Maximum diode forward voltage

$V_{CE}$  = Maximum voltage collector to emitter

$V_{LED}$  = Maximum LED forward voltage

$I_F$  = Maximum LED current

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

Typical values are characteristic of the device at +25°C, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

### Electrical Characteristics @ 25°C

Parameter	Conditions	Symbol	Min	Typ	Max	Units
<b>Output Characteristics</b>						
Blocking Voltage (Peak)	-	$V_L$	-	-	350	$V_P$
Load Current	-	$I_L$	-	-	120	$mA_{rms} / mA_{DC}$
Continuous	-	$I_L$	-	-	120	$mA_{rms} / mA_{DC}$
Peak	$t=10ms$	$I_{LPK}$	-	-	400	$mA_P$
On-Resistance	$I_L=120mA$	$R_{ON}$	-	-	15	$\Omega$
Off-State Leakage Current	$V_L=350V, T_J=25^\circ C$	$I_{LEAK}$	-	-	1	$\mu A$
Switching Speeds	-	-	-	-	-	-
Turn-On	$I_F=5mA, V_L=10V$	$t_{on}$	-	-	3	ms
Turn-Off	$I_F=5mA, V_L=10V$	$t_{off}$	-	-	3	ms
Output Capacitance	$V_L=50V, f=1MHz$	$C_{OUT}$	-	25	-	pF
<b>Input Characteristics</b>						
Input Control Current to Activate	$I_L=120mA$	$I_F$	-	-	5	mA
Input Voltage Drop	$I_F=5mA$	$V_F$	0.9	1.2	1.4	V
Reverse Input Voltage	-	$V_R$	-	-	5	V
Reverse Input Current	$V_R=5V$	$I_R$	-	-	10	$\mu A$

### Electrical Characteristics @25°C: Darlington Transistor Section

Parameter	Conditions	Symbol	Min	Typ	Max	Units
Collector-Emitter Voltage	$I_C=10mA_{DC}, I_B=0mA$	$V_{CEO}$	40	-	-	V
Collector Current, Continuous	$V_{CE}=3.5V$	$I_C$	-	-	120	mA
Power Dissipation	-	$P_D$	-	-	500	mW
Off-State Collector-Emitter Leakage Current	$V_{CE}=10V, I_B=0mA$	$I_{CEX}$	-	-	1	$\mu A$
DC Current Gain	$V_{CE}=10V_{DC}, I_C=120mA$	$h_{FE}$	10,000	-	-	-
Saturation Voltage	$I_C=120mA$	$V_{CE(sat)}$	-	-	1.5	V
Total Harmonic Distortion	$I_C=40mA, f_O=300Hz @ -10dBm$	-	-	-	-80	dB

### Electrical Characteristics @25°C: Detector Section

Parameter	Conditions	Symbol	Min	Typ	Max	Units
<b>Output Characteristics</b>						
Phototransistor Blocking Voltage	$I_C=10\mu A$	$BV_{CEO}$	20	50	-	V
Phototransistor Dark Current	$V_{CE}=5V, I_F=0mA$	$I_{CEO}$	-	50	500	nA
Saturation Voltage	$I_F=16mA, I_C=2mA$	$V_{SAT}$	-	0.3	0.5	V
Current Transfer Ratio	$I_F=6mA, V_{CE}=0.5V$	CTR	33	400	-	%
<b>Input Characteristics</b>						
Input Control Current	$I_C=2mA, V_{CE}=0.5V$	$I_F$	-	2	6	mA
Input Voltage Drop	$I_F=5mA$	$V_F$	0.9	1.2	1.4	V
Input Current (Detector Must be Off)	$I_C=1\mu A, V_{CE}=5V$	$I_F$	5	25	-	$\mu A$

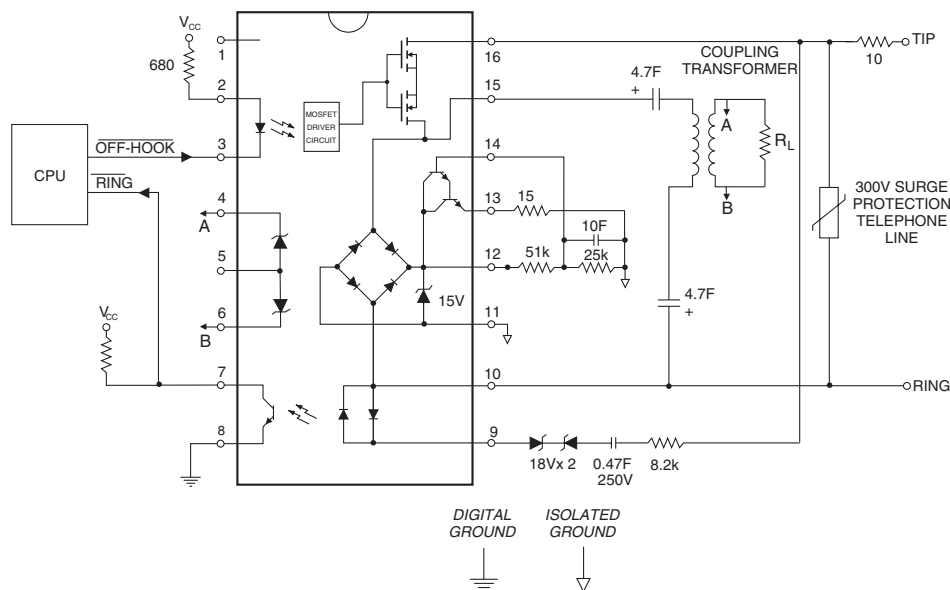
### Electrical Characteristics @25°C (Unless Otherwise Noted): Bridge Rectifier Section

Parameter	Conditions	Symbol	Min	Typ	Max	Units
Reverse Voltage	-	$V_{RD}$	-	-	100	V
Forward Voltage Drop	$I_{FD}=120mA$	$V_{FD}$	-	-	1.5	V
Reverse Leakage Current	$T_J=25^\circ C, V_R=100V$	$I_{RD}$	-	-	10	$\mu A$
	$T_J=85^\circ C$		-	-	50	
Forward Current	-	$I_{FD}$	-	-	140	mA
Continuous	-		-	-	140	
Peak	$t=10ms$		-	-	500	

### Electrical Characteristics @25°C: Zener Diodes

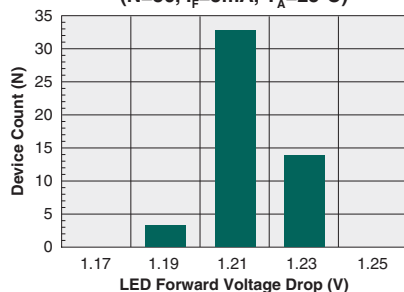
Parameter	Conditions	Symbol	Min	Typ	Max	Units
Zener Voltage Between Pins 4&5 and Pins 6&5	$I_{ZT}=20mA$	$V_Z$	-	4.3	-	V
Zener Voltage Between Pins 12&11	$I_{ZT}=20mA$	$V_Z$	-	15	-	V
Input to Output Capacitance	-	$C_{I/O}$	-	3	-	pF
Input to Output Isolation	-	$V_{I/O}$	3750	-	-	$V_{rms}$

### EXAMPLE CIRCUIT

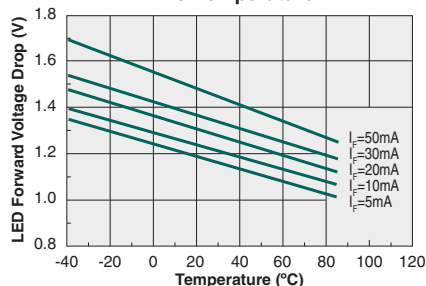


# DEVICE PERFORMANCE DATA\*

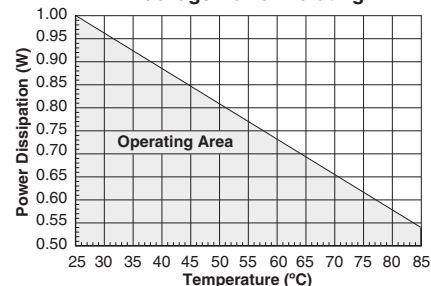
Typical LED Forward Voltage Drop  
(N=50,  $I_F=5\text{mA}$ ,  $T_A=25^\circ\text{C}$ )



Typical LED Forward Voltage Drop  
vs. Temperature

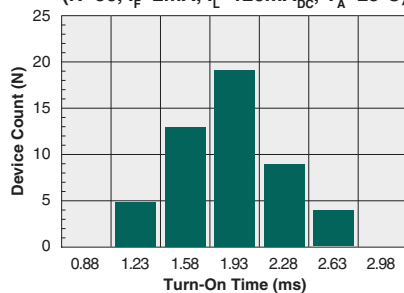


Package Power Derating

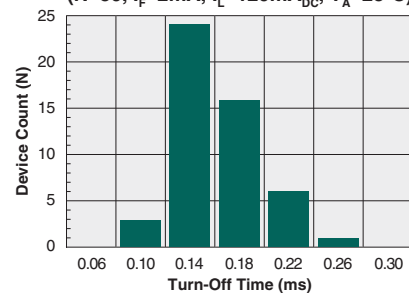


# RELAY PERFORMANCE DATA\*

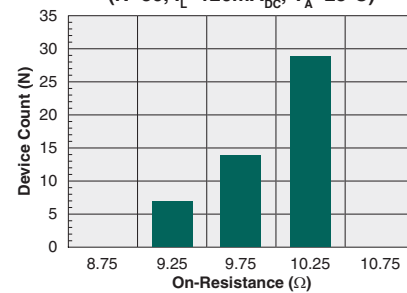
Typical Turn-On Time  
(N=50,  $I_F=2\text{mA}$ ,  $I_L=120\text{mA}_{DC}$ ,  $T_A=25^\circ\text{C}$ )



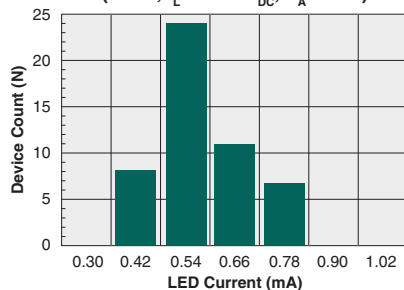
Typical Turn-Off Time  
(N=50,  $I_F=2\text{mA}$ ,  $I_L=120\text{mA}_{DC}$ ,  $T_A=25^\circ\text{C}$ )



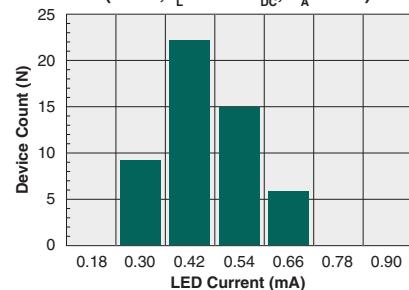
Typical On-Resistance Distribution  
(N=50,  $I_L=120\text{mA}_{DC}$ ,  $T_A=25^\circ\text{C}$ )



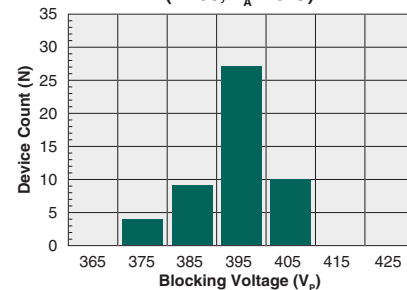
Typical  $I_F$  for Switch Operation  
(N=50,  $I_L=120\text{mA}_{DC}$ ,  $T_A=25^\circ\text{C}$ )



Typical  $I_F$  for Switch Dropout  
(N=50,  $I_L=120\text{mA}_{DC}$ ,  $T_A=25^\circ\text{C}$ )

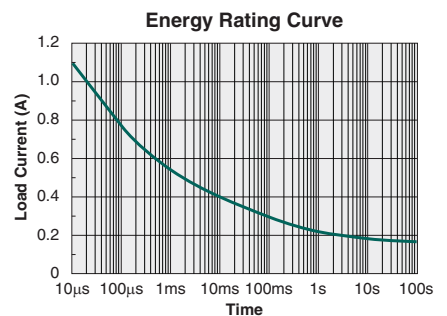
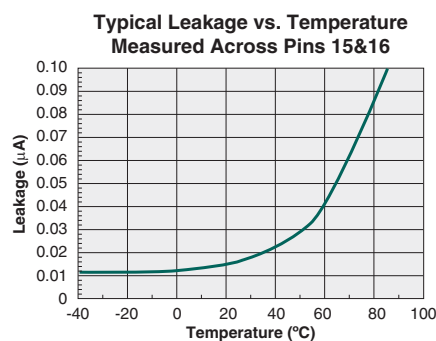
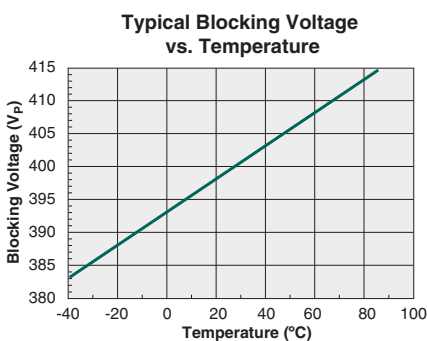
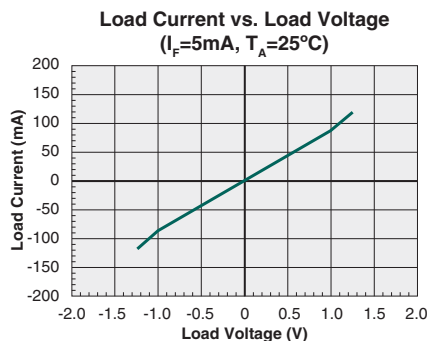
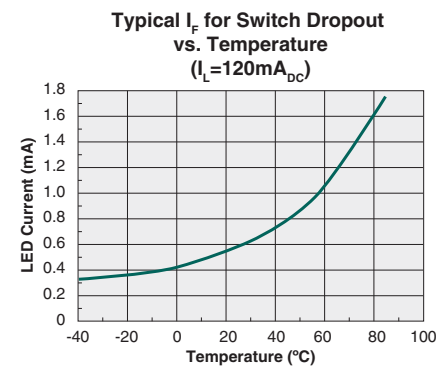
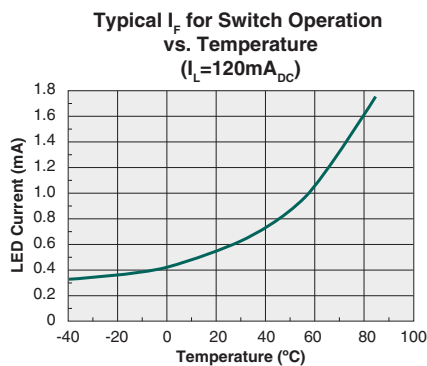
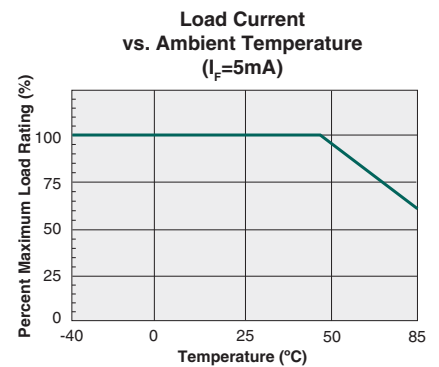
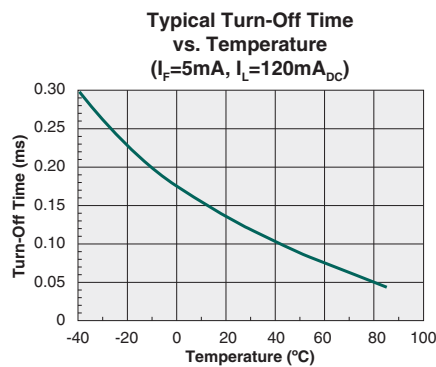
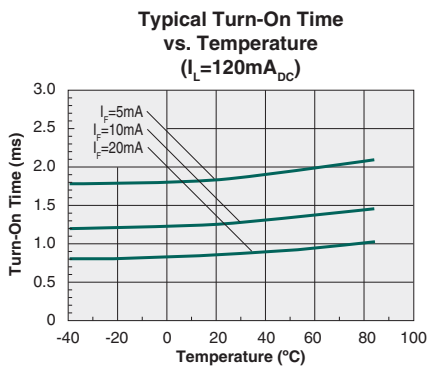
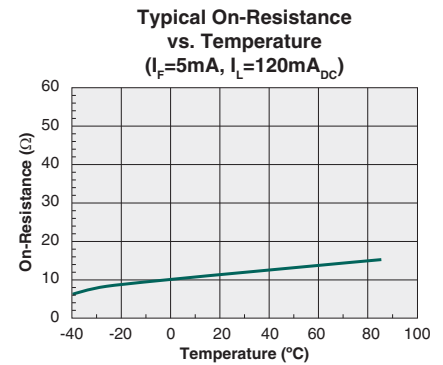
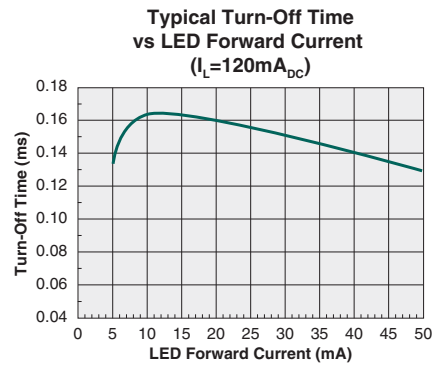
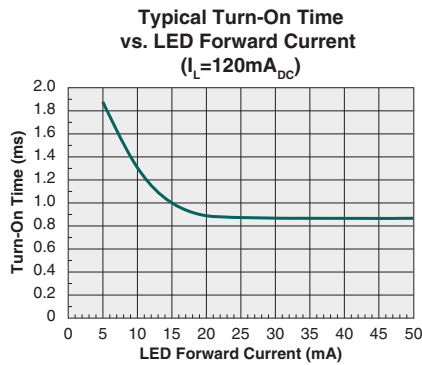


Typical Blocking Voltage Distribution  
(N=50,  $T_A=25^\circ\text{C}$ )



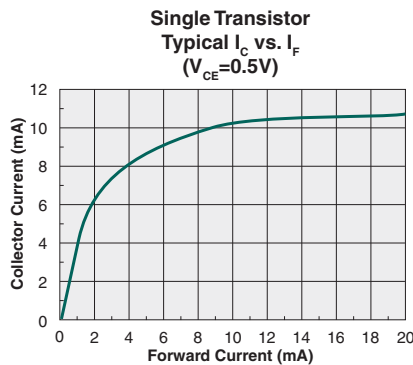
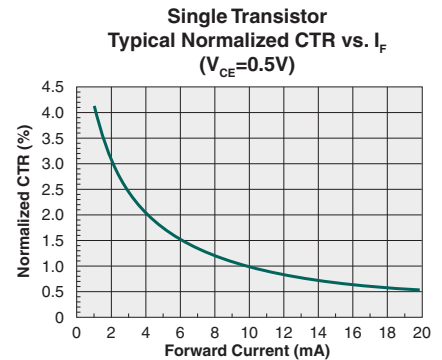
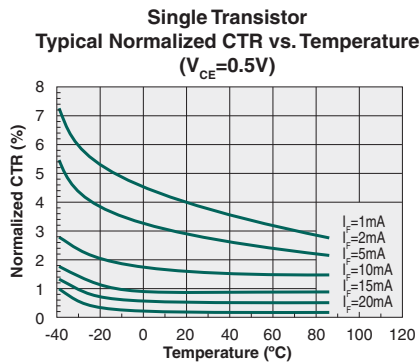
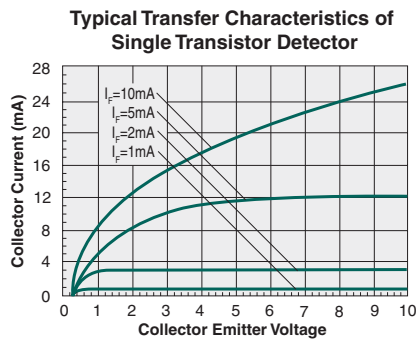
\* Unless otherwise noted, data presented in these graphs is typical of device operation at  $25^\circ\text{C}$ .

RELAY PERFORMANCE DATA (cont)\*

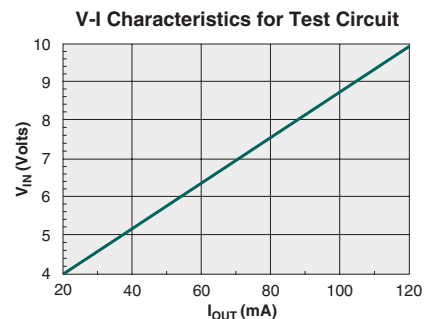
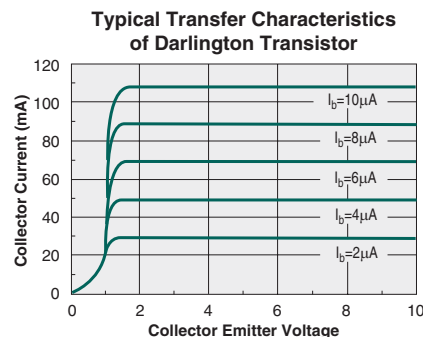
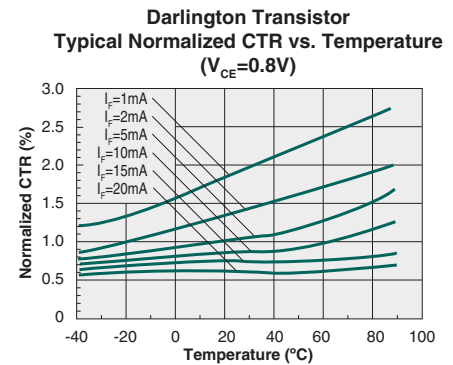
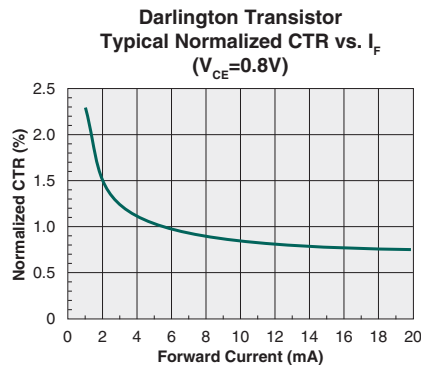
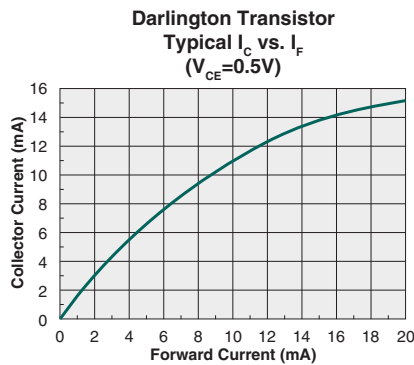


\* Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C.

### PHOTOTRANSISTOR PERFORMANCE DATA\*



### DARLINGTON PERFORMANCE DATA\*



\* Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C.

## Manufacturing Information

### Moisture Sensitivity



All plastic encapsulated semiconductor packages are susceptible to moisture ingress. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL)** classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Classification
ITC137P	MSL 3

### ESD Sensitivity



This product is ESD Sensitive, and should be handled according to the industry standard **JESD-625**.

### Soldering Profile

Provided in the table below is the **IPC/JEDEC J-STD-020** Classification Temperature ( $T_C$ ) and the maximum dwell time the body temperature of these surface mount devices may be ( $T_C - 5$ )°C or greater. The Classification Temperature sets the Maximum Body Temperature allowed for these devices during reflow soldering processes.

Device	Classification Temperature ( $T_C$ )	Dwell Time ( $t_p$ )	Max Reflow Cycles
ITC137P	245°C	30 seconds	3

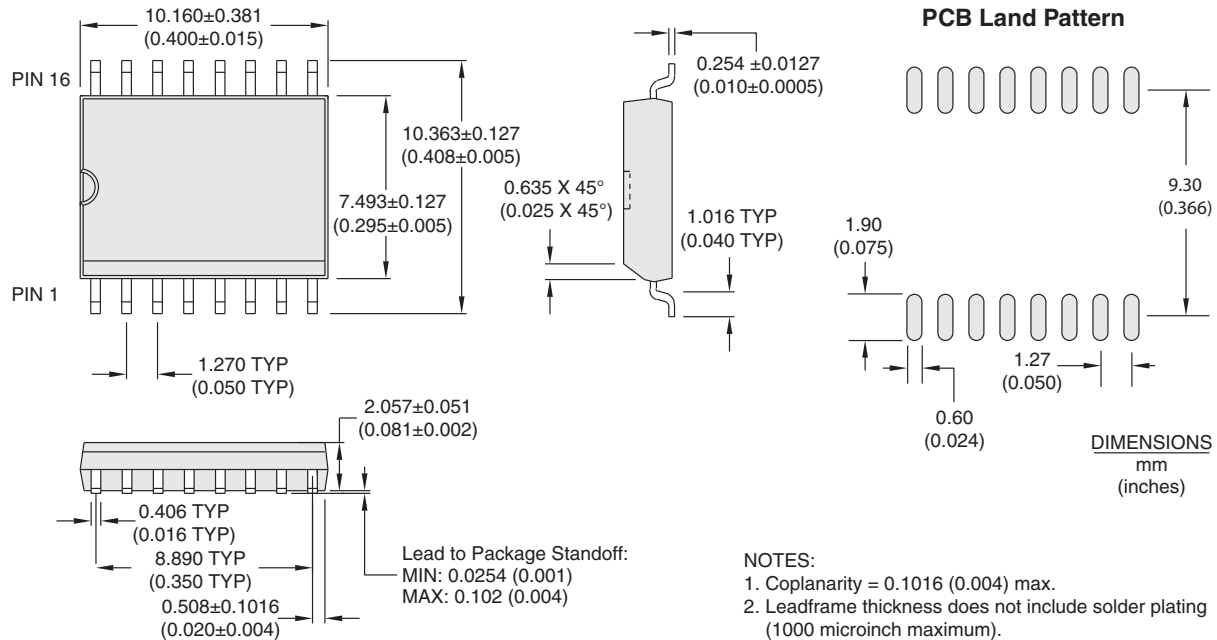
### Board Wash

IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to halide flux or solvents.

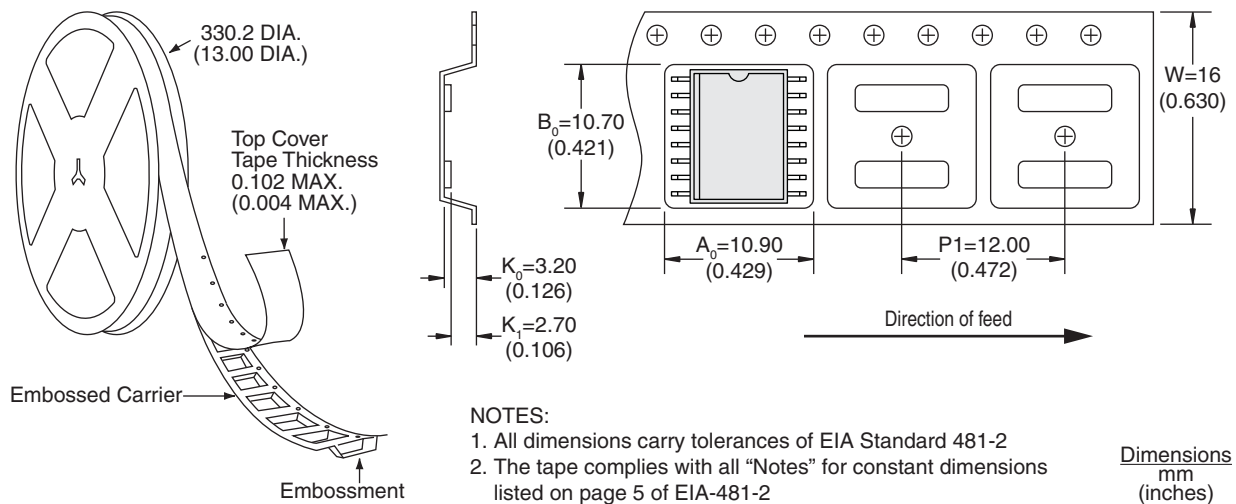


# MECHANICAL DIMENSIONS

## ITC117P



## ITC117PTR Tape & Reel



For additional information please visit our website at: <https://www.ixysic.com>